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APPLICATION NOTE 697

# Silicon Germanium (SiGe) Technology Enhances Radio Front-End Performance

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*Abstract: This application note describes how silicon germanium enhances IC performance in RF applications. A Giacoletto model is used to analyze noise effects. Wider gain bandwidth of SiGe technology is shown to provide lower noise performance. The impact of SiGe on linearity is explored.*

Three parameters are increasingly important for cellular handsets and other digital, portable, wireless communication devices. Low power consumption and lightweight batteries lend autonomy to the device, higher front-end sensitivity increases the reception distance, and greater front-end linearity has a direct impact on the admissible dynamic range. This last parameter is gaining emphasis with the advent of nonconstant-energy modulation schemes such as  $\pi/4$ DQPSK and 8QAM.

Silicon Germanium (SiGe) is the newest innovation for simultaneously improving the power consumption, sensitivity, and dynamic range of a receiver. GST-3 is a new high-speed IC process technology based on silicon germanium (SiGe), which features a transition figure ( $f_T$ ) of 35GHz. A typical front-end block diagram (Figure 1) shows the performance possible with Silicon Germanium technology (1.9GHz) for a combination mixer and low-noise amplifier (LNA).



[Click here for an overview of the wireless components used in a typical radio transceiver.](#)

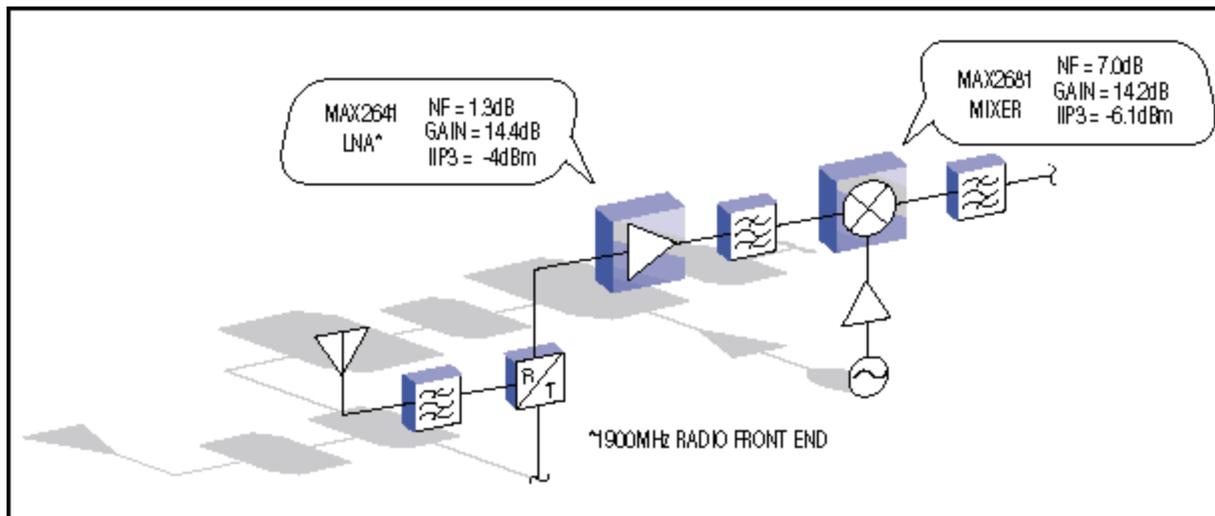


Figure 1. Typical radio input circuitry includes a low-noise amplifier and mixer.

## Noise Performance

The main contribution to noise figure in the down-conversion link is noise created by the LNA's first transistor input stage. Noise figure (NF) serves as a figure of merit for networks, to compare noise in the actual network with that in an ideal noiseless network. The noise factor (F) for an amplifier or other network with power gain (G) equal to  $G = P_{OUT}/P_{IN}$  can be expressed as:

$$F = \frac{\text{(amplifier's actual, measured output noise power)}}{\text{(amplifier's output noise power due to } R_{SOURCE})}$$

NF is a measure of the degradation in the signal-to-noise ratio (SNR) between the input and output ports of a network, typically expressed in dB:  $NF = 10 \log_{10} F$ . Therefore,

$$\begin{aligned} F &= \text{Input SNR} / \text{Output SNR} \\ &= (P_{IN}/N_{IN}) / (P_{OUT}/N_{OUT}) \\ &= N_{OUT} / (N_{IN} \cdot G) \end{aligned}$$

We are concerned with thermal noise (also called Johnson noise or white noise) and shot noise (also called Schottky noise). A detailed high-frequency equivalent model for the bipolar transistor (the Giacoletto model—see **Figure 2**) helps in understanding how this noise is generated. The model also shows how SiGe technology can help reduce the LNA's front-end noise figure.

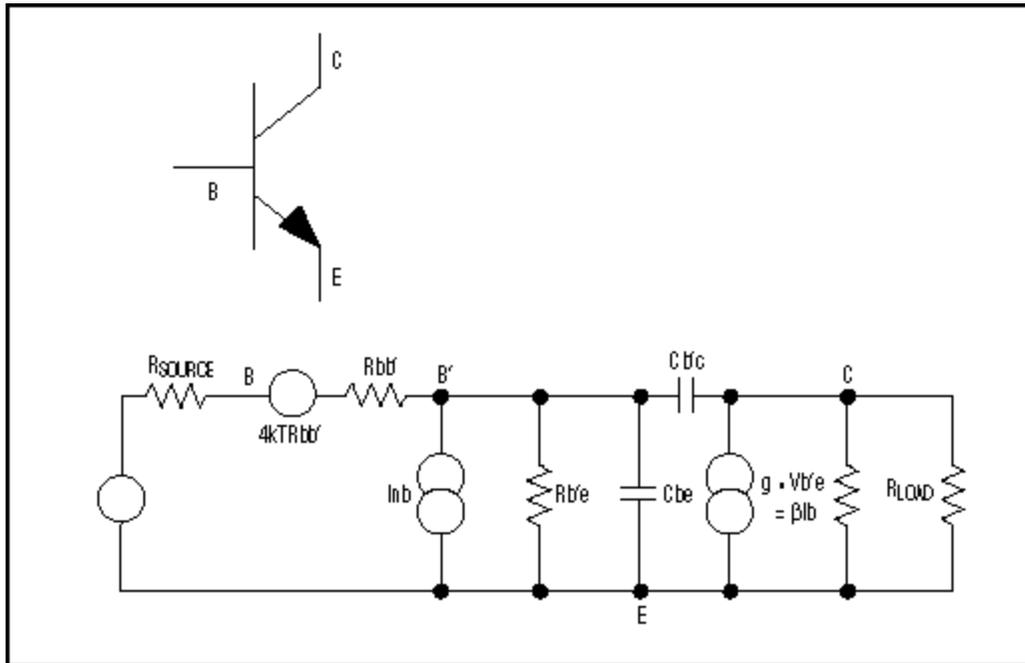


Figure 2. This detailed npn-transistor model (the Giacoletto model) simplifies the analysis of frequency effects.

## Silicon Germanium Thermal and Shot Noise

Within a conducting medium whose temperature is above absolute zero ( $0^\circ\text{K}$ ), the random motion of charge carriers produces random noise-producing voltages and currents. A rising conductor temperature increases the charge-carrier velocity of these random motions, which increases the noise voltage. The thermal noise generated by parasitic base

resistance ( $R_{bb'}$ ) in a transistor is  $V_n(f) = 4kTR_{bb'}$ , where  $V_n(f)$  equals the voltage spectral noise density in  $V^2/Hz$ . The  $k$  is Boltzmann's constant ( $1.38 \times 10^{-23}$  Joules/Kelvin), and  $T$  is the absolute temperature in degrees Kelvin ( $^{\circ}C + 273^{\circ}$ ).

Shot noise is a consequence of the particle-like nature of charge carriers. DC current flow in a semiconductor is often regarded as constant at every instant, but any current consists of individual electrons and holes. Only the time-average flow of these charge carriers appears as constant current. Any fluctuation in the number of charge carriers produces a random current at that instant, which is known as shot noise.

The spectral noise density for shot noise in the base current is  $I_{nb}(f) = 2qI_b = 2qI_c/\beta$ , where  $I_{nb}$  is the current spectral noise density in  $I^2/Hz$ ,  $I_b$  is the base dc-biasing current,  $q$  is one electron charge ( $1.6 \times 10^{-19}$  coulombs), and  $\beta$  is the transistor's DC current gain. Thus, the total noise spectral density generated by the transistor's input stage is the sum of the thermal and shot noise:

$$\gamma_n = 4kTR_{bb'} + R_{SOURCE} 2qI_c/\beta$$

Maxim's new SiGe process, GST-3, was created as an extension of GST-2 (a bipolar process with a transition frequency of 27GHz) by doping the transistor bases with germanium. The result was an important decrease in  $R_{bb'}$  and a significant increase in the transistor beta. The combined effect of these two changes is better noise figure for the SiGe transistor (vs. that of a silicon transistor with similar collector current). Typically, the transistor noise figure is expressed as:

$$F = 1 + \frac{V_n^2(f)/R_{SOURCE} + I_{nb}^2(f) \cdot R_{SOURCE}}{4kT}$$

Because  $R_{SOURCE} = V_n(f)/I_{nb}(f)$  gives a minimum noise figure for Si-bipolar as well as Silicon Germanium technology, the full benefits of the SiGe process can be obtained by designing an LNA with source impedance close to this value.

Another important aspect of wireless design is the derating of noise figure vs. frequency. The power gain of a typical transistor is similar to the upper curve in **Figure 3**. This curve is not surprising, considering the equivalent transistor circuit of Figure 2. In effect, the model is an RC lowpass filter whose gain falls off at 6dB per octave. The maximum theoretical frequency for which the common-emitter current gain ( $\beta$ ) is unity (0dB) is called the transition frequency ( $f_T$ ). An LNA's gain ( $G$ ) depends directly on  $\beta$ , so the derating of noise figure [ $F = N_{OUT}/(N_{IN}G)$ ] begins with the rolloff of gain.

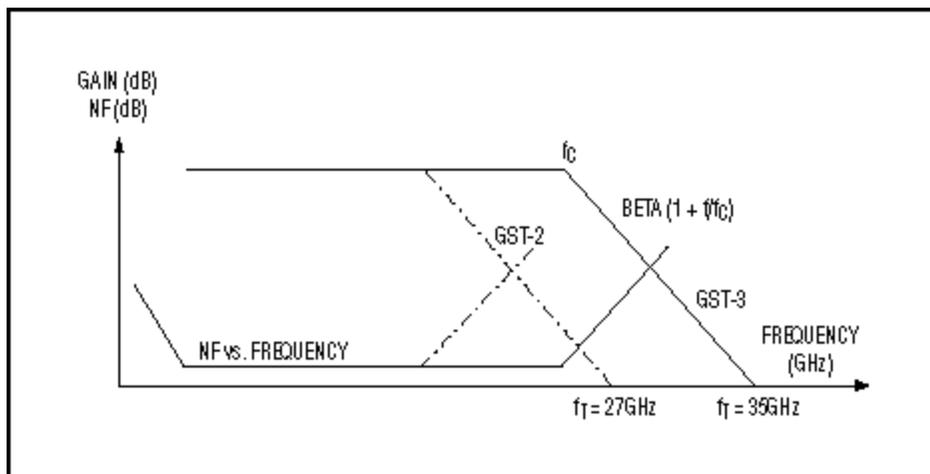


Figure 3. Silicon Germanium (SiGe) bipolar transistors exhibit high gain and low noise.

To see how the GST-3 SiGe process improves noise figure at high frequencies, consider that adding germanium to the

p-silicon base of a transistor reduces the bandgap by 80mV to 100mV across the base, creating a strong electric field between the emitter and collector junctions. By rapidly sweeping electrons from the base into the collector, this electric field reduces the transit time ( $t_b$ ) required for carriers to cross the narrow base. If all other factors are held constant, this reduced  $t_b$  provides an approximate 30% increase in  $f_T$ .

For identical-area transistors, the Silicon Germanium device achieves a given  $f_T$  with one-half to one-third the current required in a GST-2 device. Higher  $f_T$  reduces high-frequency noise, because the  $\beta$  rolloff occurs at a higher frequency.

## Ultra-low-noise SiGe Amplifier (MAX2641)

The Silicon Germanium MAX2641 offers advantages over silicon-bipolar LNAs, whose NF falls off for frequencies approaching the 2GHz limit (i.e., 1.5dB at 1GHz vs. 2.5dB at 2GHz). High reverse isolation in the SiGe device also allows tuning of the input-matching network without affecting the output matching, and vice versa.

The Silicon Germanium MAX2641 is optimized for operation in the 1400MHz to 2500MHz range, with typical performance that includes 14.4dB gain, -4dBm input IP3 (IIP3), 30dB reverse isolation, and a 1.3dB noise figure at 1900MHz (**Figure 4**). Available in 6-pin SOT23 packages, it operates from a +2.7V to +5.5V single supply, draws 3.5mA, and is internally biased. The only external components typically required are a two-element input match, input and output blocking capacitors, and a  $V_{CC}$  bypass capacitor.

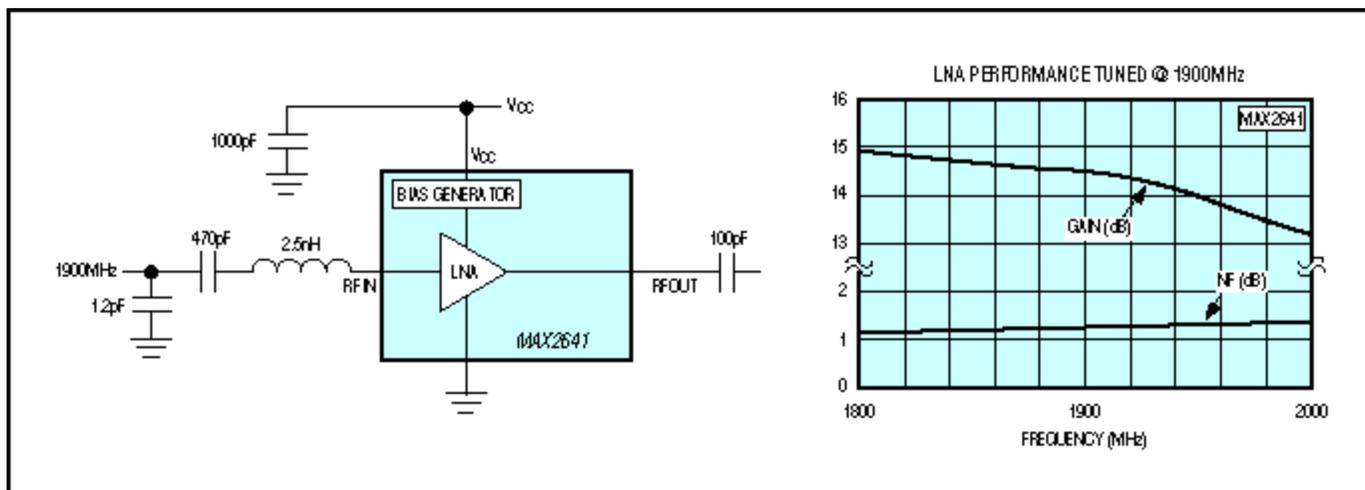


Figure 4. Note the very low noise figure for this Silicon Germanium integrated-circuit low-noise amplifier.

## Linearity

In addition to noise and finite bandwidth, communication systems are limited by signal distortion. The system's usefulness depends on its dynamic range (i.e., the signal range it can process with high quality). Dynamic range is dictated by noise figure, whose lower limit is defined by the sensitivity level and whose upper limit is defined by the acceptable maximum level of signal distortion. Achieving the optimum dynamic range involves trade-offs among power consumption, output signal distortion, and the level of input signal with respect to noise.

A typical receiver block diagram (Figure 1) shows the relative importance of noise figure and linearity for the LNA and mixer. Because the LNA input is supplied directly by a very low-level signal from the antenna, its NF is the dominant parameter. For the mixer, fed by an amplified signal from the LNA output, linearity is the dominant parameter.

The output is never an exact replica of the input signal because no transistor is perfectly linear. The output signal always includes harmonics, intermodulation distortion (IMD), and other spurious components. In **Figure 5**, the second term of the  $P_{OUT}$  equation is called the second harmonic or second-order distortion, and the third term is called the third harmonic or

third-order distortion. Both are characterized by driving the device input with a signal consisting of one tone or two pure sinusoidal tones closely spaced in frequency. Third-order intermodulation distortion for the MAX2681, for example, is characterized with a -25dBm signal consisting of tones at 1950MHz and 1951MHz.

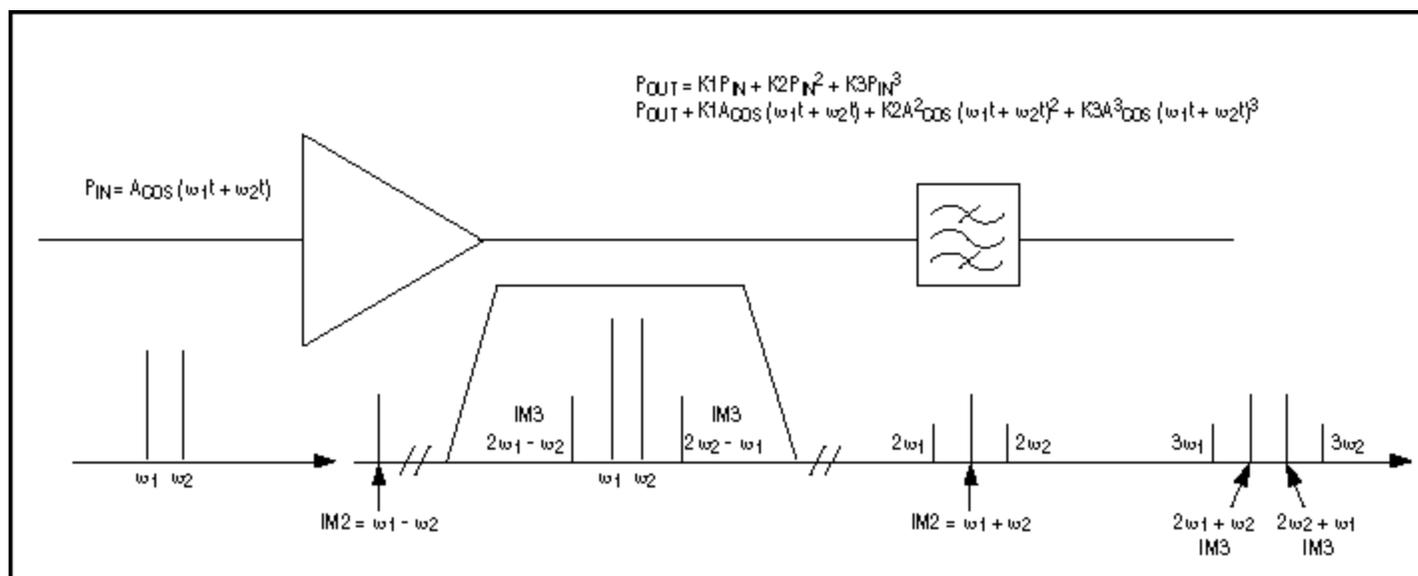


Figure 5. A two-tone test characterizes harmonic and intermodulation distortion.

A graphic frequency-domain representation of the  $P_{OUT}$  equation shows that the output consists of fundamental frequencies  $\omega_1$  and  $\omega_2$ , second harmonics  $2\omega_1$  and  $2\omega_2$ , third harmonics  $3\omega_1$  and  $3\omega_2$ , the second-order intermodulation product IM2, and the third-order intermodulation product IM3. Figure 5 also shows that in cellular handsets and other systems with narrow-band operating frequencies (i.e., a few tens of megahertz, and less than an octave), only the IM3 spurious signals  $(2\omega_1 - \omega_2)$  and  $(2\omega_2 - \omega_1)$  fall within the filter passband. The result can be distortion in the desired signals associated with  $\omega_1$  and  $\omega_2$ .

In the  $P_{OUT}$  equation for low levels of output power, coefficient  $K1A$  is directly proportional to the input signal amplitude,  $K2A^2$  is proportional to the square, and  $K3A^3$  is proportional to the cube of the input amplitude. Thus, the plot of each on a log scale is a straight line with slope corresponding to the order of the response.

Second- and third-order intercept points are often used as figures of merit. The higher the intercept point, the better the device can amplify large signals. At higher power levels, the output response is compressed and therefore deviates from the response of the fundamental. This deviation point (**Figure 6a**) is defined as the 1dB compression point, and is situated where the output signal compresses by 1dB ( $G_{1dB} = G - 1dB$ ) with respect to an extrapolation of the linear portion of the curve.

From the MAX2681 data sheet,  $P_{OUT}$  vs. frequency above 1900MHz shows a -56dBc spurious-free dynamic range (SFDR) relative to IM3 (**Figure 6b**). The typical operating conditions are  $PRF_{IN} = -25dBm$ ,  $IIP3 = 0.5dBm$ , and conversion gain = 8.4dB. LO-to-IF leakage and other spurious artifacts can be filtered by a narrow-bandpass IF filter, as shown in Figure 1. The MAX2681 (a SiGe double-balanced downconverter) achieves this performance with typical  $I_{CC}$  currents of only 8.7mA.

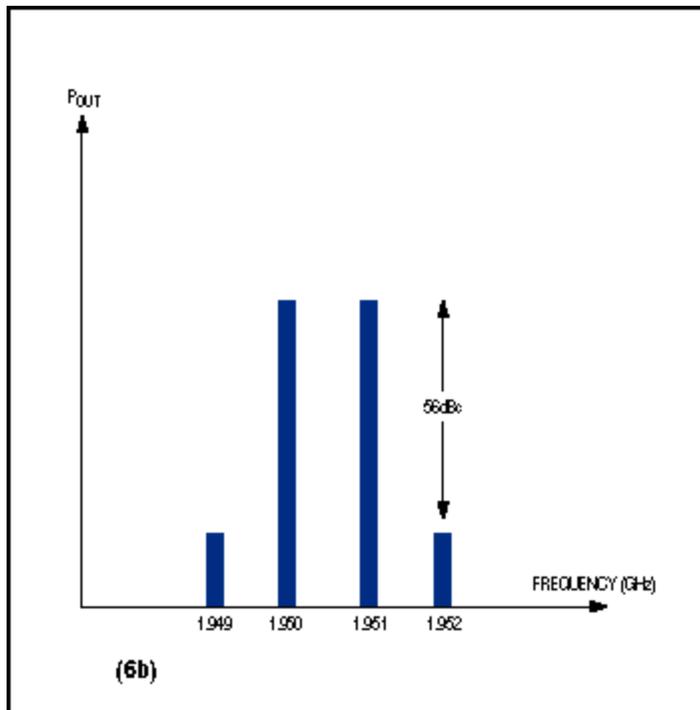
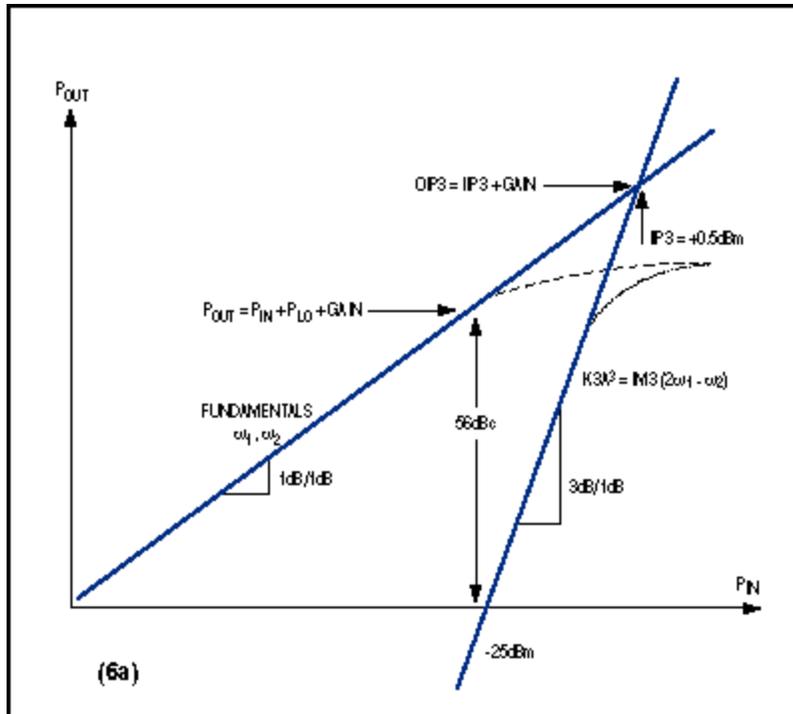


Figure 6. This Silicon Germanium double-balanced downconverter provides a low (0.5dBm) IIP3 level (a) and a 56dBc dynamic range (b).

Another downconverter mixer (MAX2680) offers different performance specifications. Available in a miniature 6-pin SOT23 package, it consists of a double-balanced Gilbert-cell mixer with single-ended RF, LO, and IF port connections. Like the MAX2681, it operates from a single +2.7V to +5.5V supply, accepts RF inputs between 400MHz and 2500MHz, and downconverts to IF outputs between 10MHz and 500MHz. Supply current in shutdown mode is typically less than

0.1μA. The LO input is a single-ended broadband port whose typical input VSWR (400MHz to 2.5GHz) is better than 2.0:1.

## Front-end Input Sensitivity

To evaluate the front-end sensitivity achievable using MAX2641/MAX2681 downconverters, consider QPSK modulation with a 4MHz signal bandwidth. To simplify calculations, assume a perfect rectangular input filter. First, a 3dB NF (AntNF) must be added to counteract a 3dB insertion loss caused by the antenna switch and front-end passive filter. Next, a post-LNA filter is added to eliminate distortion (other than IM3 distortion) generated by the LNA. Consider using a filter with 2dB of attenuation and NF for this purpose. At 1900MHz, the post-LNA filter NF adds to the MAX2681's 11.1dB NF:

$$\text{Total NF} = \text{filter NF} + \text{mixer NF} = \\ 2\text{dB} + 11.1\text{dB} = 13.1\text{dB}$$

The LNA input needs high NF because it is supplied directly by a very low-level signal from the antenna. The mixer NF is attenuated by LNA gain:

$$\text{Total NF} = \text{LNA NF} + (1/G_{\text{LNA}})(\text{NF}_{\text{TOTAL}} - 1) = 2.054; \\ \text{NF}_{\text{TOTAL}} (\text{dB}) = 10\log 2.126 = 3.12\text{dB}.$$

With QPSK modulation and a  $10^{-3}$  BER, the minimum required ratio of bit energy to noise energy at the antenna input is  $E_b/N_o = 6.5\text{dB}$ . The absolute noise floor at +25°C is  $\text{AbsNfl} = -174\text{dBm} = 10\log(KT)$ , where  $T = +300^\circ\text{K}$  and  $K = 1.38 \times 10^{-23}$ . The filter bandwidth in dB is  $\text{FiltBwth} = 10\log(4\text{MHz}) = 66\text{dB}$ . In Figure 1, the front-end sensitivity for QPSK modulation with  $10^{-3}$  BER is estimated as:

$$\text{Input sensitivity} = \text{AbsNfl} + \text{AntNF} + \text{FiltBwth} + \text{NF}_{\text{total}} + E_b/N_o \\ = -174\text{dBm} + 3\text{dB} + 66\text{dB} + 3.12\text{dB} + 6.5\text{dB} = -95.38\text{dBm}.$$

## Conclusion

When compared with pure bipolar processes, SiGe provides a lower noise figure vs. frequency for frequencies exceeding 1.0GHz. It also provides lower supply current and higher linearity. Maxim has demonstrated a high-linearity silicon germanium mixer that exhibits a typical IIP3 of 0.5dBm at 1900MHz and a noise figure of 11.1dB (SSB) with conversion gain of 8.4dB, while drawing only 8.7mA of supply current. The higher frequency operation permitted by Silicon Germanium's higher transition frequency ( $f_T$ ) enables applications through 5GHz.

## References

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### Related Parts

[MAX2247](#)

2.4GHz SiGe Linear Power Amplifier

MAX2321	Adjustable, High-Linearity, SiGe, Dual-Band, LNA/Mixer ICs	
MAX2323	Triple/Dual-Mode CDMA LNA/Mixers	
MAX2338	Triple/Dual-Mode CDMA LNA/Mixers	
MAX2640	300MHz to 2500MHz SiGe Ultra-Low-Noise Amplifiers	
MAX2642	900MHz SiGe, High-Variable IP3, Low-Noise Amplifier	<a href="#">Free Samples</a>
MAX2644	2.4GHz SiGe, High IP3 Low-Noise Amplifier	<a href="#">Free Samples</a>
MAX2645	3.4GHz to 3.8GHz SiGe Low-Noise Amplifier/PA Predriver	<a href="#">Free Samples</a>
MAX2648	5GHz to 6GHz Low-Noise Amplifier in 6-Pin UCSP	
MAX2649	5GHz Low-Noise Amplifier with Shutdown	
MAX2651	GSM900 and DCS1800/PCS1900 Dual-Band, Low-Noise Amplifiers	
MAX2654	1575MHz/1900MHz Variable-IP3 Low-Noise Amplifiers	<a href="#">Free Samples</a>
MAX2680	400MHz to 2.5GHz, Low-Noise, SiGe Downconverter Mixers	
MAX2683	3.5GHz Downconverter Mixers with Selectable LO Doubler	
MAX3273	+3.3V, 2.5Gbps Low-Power Laser Driver	<a href="#">Free Samples</a>
MAX3892	+3.3V, 2.5Gbps/2.7Gbps, SDH/SONET 4:1 Serializer with Clock Synthesis	<a href="#">Free Samples</a>
MAX9987	+14dBm to +20dBm LO Buffers/Splitters with $\pm 1$ dB Variation	<a href="#">Free Samples</a>
MAX9988	+14dBm to +20dBm LO Buffers/Splitters with $\pm 1$ dB Variation	<a href="#">Free Samples</a>

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